EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	33	navcom.as.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/20 16:30

Advanced Search: Examiners' Electronic Digest Database (EEDD)

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L15	2	((local adj reference) and (floating adj ambiguity)).clm.	US-PGPUB	OR	ON	2006/02/20 16:58
L16	1	(((real adj time adj kinematic) (realtime adj kinematic) RTK) and (floating adj ambiguity)).clm.	US-PGPUB	OR	ON	2006/02/20 16:57
L17	2	((reference adj receiver) and (floating adj ambiguity)).clm.	US-PGPUB	OR	ON	2006/02/20 16:58

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